

Computer Vision Enhances the Potential of Ultrabroadband Imaging in Non-destructive Testing

A New Approach Using Carbon nanotube tomography & visual-hull

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Summary

Led by Assistant Prof. Kou Li, a research group in Chuo University (President: KAWAI Hisashi, Hachiojishi, Tokyo, Japan), under a collaboration with National Institute of Informatics (Director-General: KUROHASHI Sadao, Chiyoda-ku, Tokyo, Japan), has developed a synergetic strategy among millimeterwave-terahertz-infrared photo-monitoring and computer vision three-dimensional modelling toward ubiquitous non-destructive inspections, with a recent paper publication in *Advanced Materials Technologies*.



While non-destructive inspections of daily necessities and industrial products require material composition identifications and structural reconstructions of composite multi-layered three-dimensional (3D) objects, the development of analyzing systems that fully satisfy those performances is still insufficient. Particularly, synergetic combinations are urgently indispensable among non-destructive permeable inner material identifications with millimeter-wave (MMW)–terahertz (THz)–infrared (IR) photo-monitoring and computer-vision (CV)-driven 3D modelling. However, respective approaches on the above individual concept crucially regulate their use as planar image acquisition operations for the former (missing cross-sectional information) and visual light (Vis)-based outer views for the latter (lacking non-destructive permeability to inner structures).

To this end, this manuscript made the following significant contributions.

- Integrating multi-wavelength MMW-IR monitoring functions into carbon nanotube (CNT) film photo-thermoelectric (PTE) imagers, which works in ultrabroadband ranges over conventional wideband sensors at comparable sensitivities with those of existing narrow-band detectors in each region.
- ii) Hybrid multi-CV operations among visual hull (VH) and Computed tomography (CT) with the CNT film PTE imager-based MMW–IR monitoring system as follows: speculating 3D spatial locations of each constituent material of targets by VH (shadow/silhouette-based vague views) as a first step of non-destructive inspections, then restores their detailed cross-sectional structures (e.g., columnar? or hollow?) by CT.
- Demonstrating material-identifying non-destructive structural reconstructions against multi-layered composite opaque 3D target objects by incorporating the aforementioned fundamental device and system preparations.
- iv) Satisfying fundamental performances (1 mm resolution at 150 sec. for VH and 2 min. for CT) comparable to existing Vis-reconstruction methods by the presenting system, while the CNT film PTE imager fully functions over 1.15 mm–660 nm wavelength ranges beyond the above conventional CV approaches.

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